

# INTERNATIONAL STANDARD

# IEC 60384-21

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## Fixed capacitors for use in electronic equipment – Part 21: Sectional specification: Fixed surface mount multilayer capacitors of ceramic dielectric, Class 1

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## INTERNATIONAL ELECTROTECHNICAL COMMISSION

**FIXED CAPACITORS FOR USE IN ELECTRONIC EQUIPMENT –****Part 21: Sectional specification:  
Fixed surface mount multilayer capacitors  
of ceramic dielectric, Class 1**

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International Standard IEC 60384-21 has been prepared by IEC technical committee 40: Capacitors and resistors for electronic equipment.

This standard and its related publications (CEI 60384-21-1, IEC 60384-22 and IEC 60384-22-1) cancel and replace IEC 60384-10 (1989) and its Amendments 1 (1993) and 2 (2000) as well as IEC 60384-10-1 (1989) and its Amendment 1 (1993).

The text of this standard is based on the following documents:

FDIS	Report on voting
40/1420/FDIS	40/1451/RVD

Full information on the voting for the approval of this standard can be found in the report on voting indicated in the above table.

This publication has been drafted in accordance with the ISO/IEC Directives, Part 2.

The committee has decided that the contents of this publication will remain unchanged until the maintenance result date indicated on the IEC web site under "<http://webstore.iec.ch>" in the data related to the specific publication. At this date, the publication will be

- reconfirmed;
- withdrawn;
- replaced by a revised edition, or
- amended.

A bilingual version of this standard may be issued at a later date.

## **FIXED CAPACITORS FOR USE IN ELECTRONIC EQUIPMENT –**

### **Part 21: Sectional specification: Fixed surface mount multilayer capacitors of ceramic dielectric, Class 1**

#### **1 General**

##### **1.1 Scope**

This sectional specification is applicable to fixed unencapsulated surface mount multilayer capacitors of ceramic dielectric, Class 1, for use in electronic equipment. These capacitors have metallized connecting pads or soldering strips and are intended to be mounted on printed boards, or directly onto substrates for hybrid circuits.

Capacitors for electromagnetic interference suppression are not included, but are covered by IEC 60384-14.

##### **1.2 Object**

The object of this standard is to prescribe preferred ratings and characteristics and to select from IEC 60384-1:1999 the appropriate quality assessment procedures, tests and measuring methods and to give general performance requirements for this type of capacitor. Test severities and requirements prescribed in detail specifications referring to this sectional specification shall be of equal or higher performance level, lower performance levels are not permitted.

##### **1.3 Normative references**

The following referenced documents are indispensable for the application of this document. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

IEC 60063:1963, *Preferred number series for resistors and capacitors*  
Amendment 1 (1967)  
Amendment 2 (1977))

IEC 60068-1:1988, *Environmental testing – Part 1: General and guidance*

IEC 60068-2-58:1999, *Environmental testing – Part 2-58: Tests – Test Td – Test methods for solderability, resistance to dissolution of metallization and to soldering heat of surface mounting devices (SMD)*

IEC 60384-1:1999, *Fixed capacitors for use in electronic equipment – Part 1: Generic specification*

IEC 60410:1973, *Sampling plans and procedures for inspection by attributes*

ISO 3 :1973, *Preferred numbers – Series of preferred numbers*